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FDD8447L

40V N-Channel PowerTrench[®] MOSFET

40V, 50A, 8.5mΩ

Features

- Max $r_{DS(on)}$ = 8.5mΩ at $V_{GS} = 10V$, $I_D = 14A$
- Max $r_{DS(on)}$ = 11.0mΩ at $V_{GS} = 4.5V$, $I_D = 11A$
- Fast Switching
- RoHS Compliant

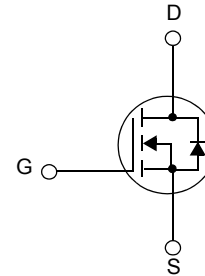
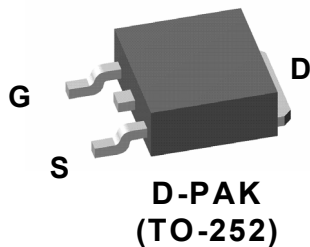


General Description

This N-Channel MOSFET has been produced using Fairchild Semiconductor's proprietary PowerTrench[®] technology to deliver low $r_{DS(on)}$ and optimized BV_{DSS} capability to offer superior performance benefit in the application.

Applications

- Inverter
- Power Supplies



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|----------------|--|-------------|------------------|
| V_{DS} | Drain to Source Voltage | 40 | V |
| V_{GS} | Gate to Source Voltage | ±20 | V |
| I_D | Drain Current -Continuous (Package limited) $T_C = 25^\circ\text{C}$ | 50 | A |
| | -Continuous (Silicon limited) $T_C = 25^\circ\text{C}$ | 57 | |
| | -Continuous $T_A = 25^\circ\text{C}$ (Note 1a) | 15.2 | |
| | -Pulsed | 100 | |
| I_S | Max Pulse Diode Current | 100 | A |
| E_{AS} | Drain-Source Avalanche Energy (Note 3) | 153 | mJ |
| P_D | Power Dissipation $T_C = 25^\circ\text{C}$ | 44 | W |
| | $T_A = 25^\circ\text{C}$ (Note 1a) | 3.1 | |
| | $T_A = 25^\circ\text{C}$ (Note 1b) | 1.3 | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to +150 | $^\circ\text{C}$ |

Thermal Characteristics

| | | | |
|-----------------|---|-----|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 2.8 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 40 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1b) | 96 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|---------------|-----------|------------|------------|
| FDD8447L | FDD8447L | D-PAK(TO-252) | 13" | 16mm | 2500 units |

FDD8447L 40V N-Channel PowerTrench[®] MOSFET

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | |
|--------------------------------------|---|---|----|----|-----------|----------------------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ | 40 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$, referenced to 25°C | | 35 | | mV/ $^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 32\text{V}, V_{GS} = 0\text{V}$ | | | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$ | | | ± 100 | nA |

On Characteristics (Note 2)

| | | | | | | |
|--|--|--|-----|------|------|----------------------|
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | 1.0 | 1.9 | 3.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\mu\text{A}$, referenced to 25°C | | -5 | | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{V}, I_D = 14\text{A}$ | | 7.0 | 8.5 | m Ω |
| | | $V_{GS} = 4.5\text{V}, I_D = 11\text{A}$ | | 8.5 | 11.0 | |
| | | $V_{GS} = 10\text{V}, I_D = 14\text{A}, T_J = 125^\circ\text{C}$ | | 10.4 | 14.0 | |
| g_{FS} | Forward Transconductance | $V_{DS} = 5\text{V}, I_D = 14\text{A}$ | | 58 | | S |

Dynamic Characteristics

| | | | | | | |
|-----------|------------------------------|--|--|------|--|----------|
| C_{iss} | Input Capacitance | $V_{DS} = 20\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | | 1970 | | pF |
| C_{oss} | Output Capacitance | | | 250 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 150 | | pF |
| R_g | Gate Resistance | $f = 1\text{MHz}$ | | 1.27 | | Ω |

Switching Characteristics

| | | | | | | |
|--------------|--|--|--|----|----|----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 20\text{V}, I_D = 1\text{A}$ $V_{GS} = 10\text{V}, R_{GEN} = 6\Omega$ | | 12 | 21 | ns |
| t_r | Rise Time | | | 12 | 21 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 38 | 61 | ns |
| t_f | Fall Time | | | 9 | 18 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge, $V_{GS} = 10\text{V}$ | $V_{DD} = 20\text{V}, I_D = 14\text{A}$ $V_{GS} = 10\text{V}$ | | 37 | 52 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge, $V_{GS} = 5\text{V}$ | | | 20 | 28 | nC |
| Q_{gs} | Gate to Source Gate Charge | | | 6 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | 7 | | nC |

Drain-Source Diode Characteristics

| | | | | | | |
|----------|---|---|--|-----|-----|----|
| I_S | Maximum Continuous Drain-Source Diode Forward Current (Note 1a) | | | 2.6 | A | |
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{V}, I_S = 14\text{A}$ (Note 2) | | 0.8 | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $I_F = 14\text{A}, di/dt = 100\text{A}/\mu\text{s}$ | | 22 | | ns |
| Q_{rr} | Reverse Recovery Charge | | | 11 | | nC |

Notes:

- $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
 - $40^\circ\text{C}/\text{W}$ when mounted on a 1 in2 pad of 2 oz copper
 - $96^\circ\text{C}/\text{W}$ when mounted on a minimum pad.
- Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%.
- Starting $T_J = 25^\circ\text{C}$, $L = 1\text{mH}$, $I_{AS} = 17.5\text{A}$, $V_{DD} = 40\text{V}$, $V_{GS} = 10\text{V}$.

Typical Characteristics

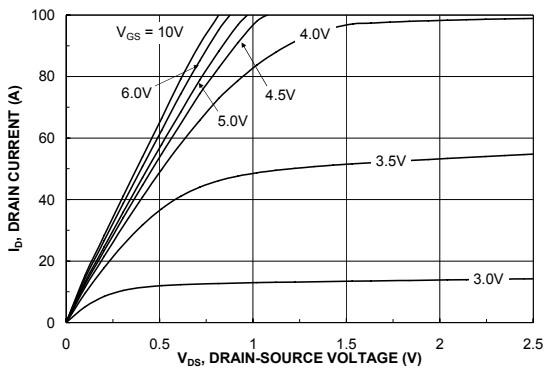


Figure 1. On-Region Characteristics

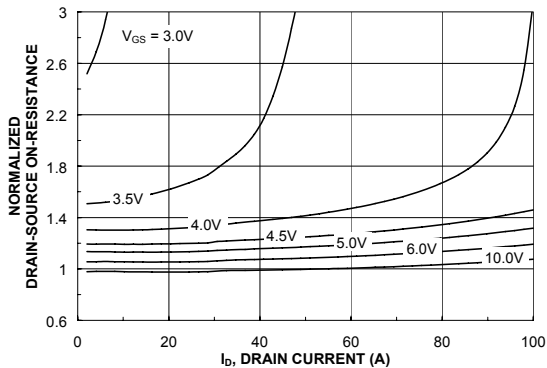


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

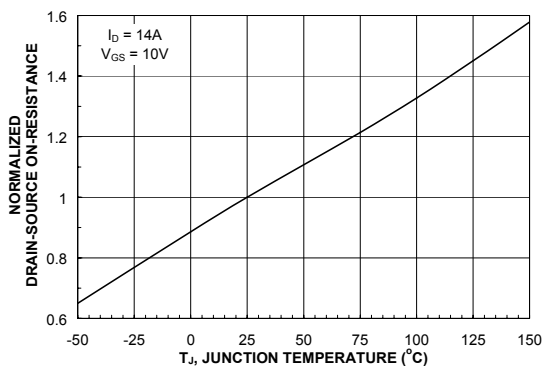


Figure 3. On-Resistance Variation with Temperature

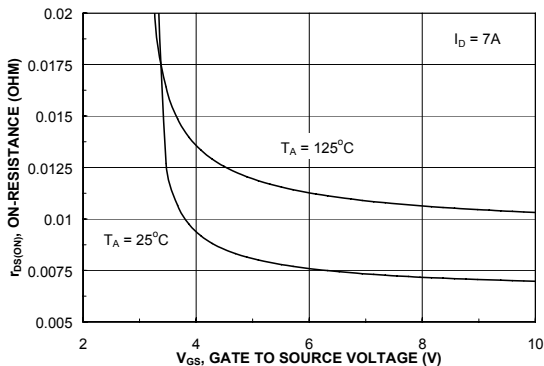


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

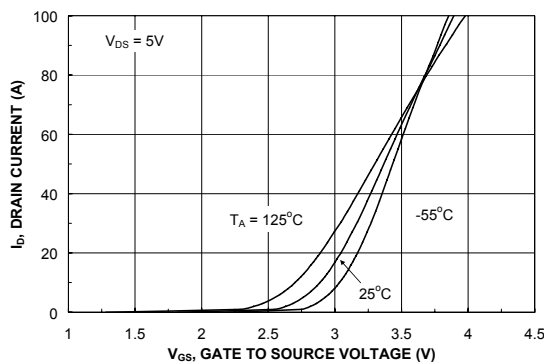


Figure 5. Transfer Characteristics

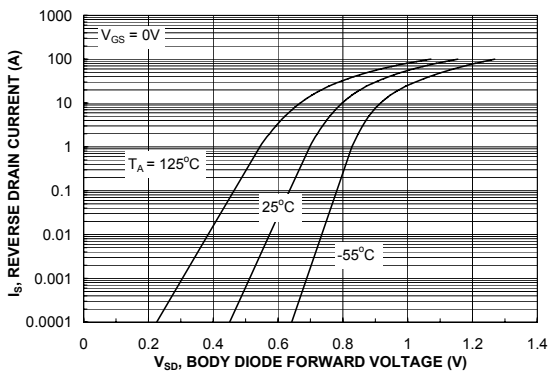


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

Typical Characteristics

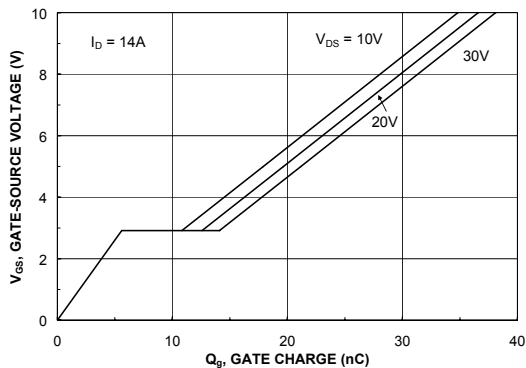


Figure 7. Gate Charge Characteristics

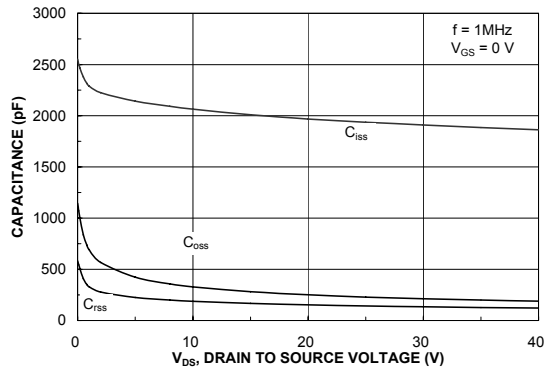


Figure 8. Capacitance Characteristics

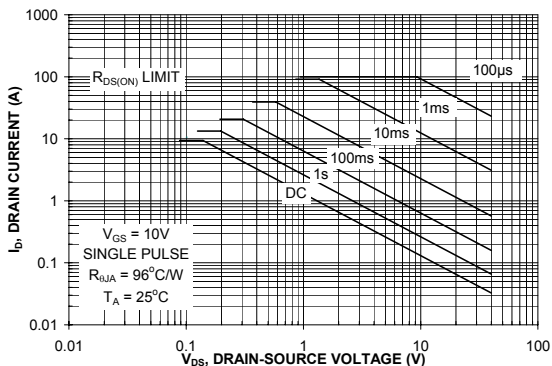


Figure 9. Maximum Safe Operating Area

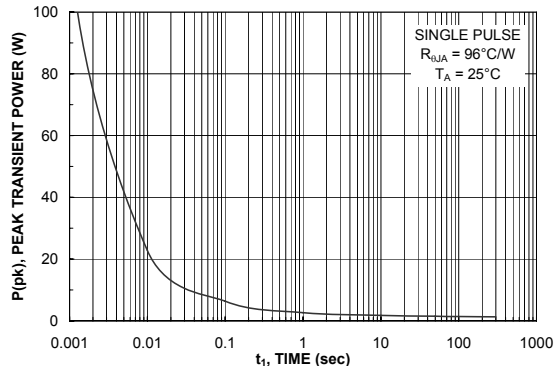


Figure 10. Single Pulse Maximum Power Dissipation

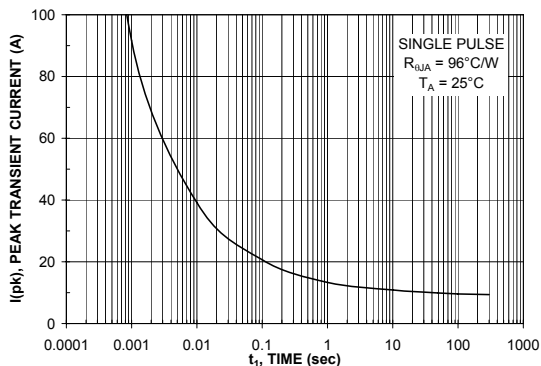


Figure 11. Single Pulse Maximum Peak Current

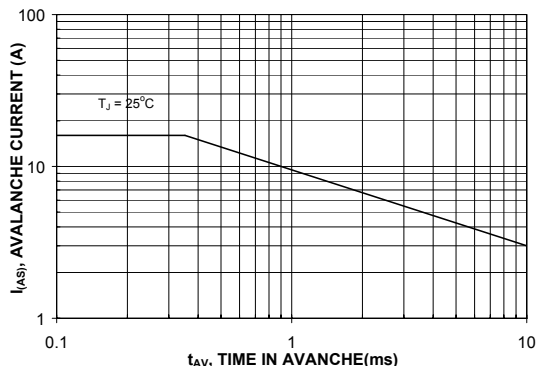


Figure 12. Unclamped Inductive Switching Capability

Typical Characteristics

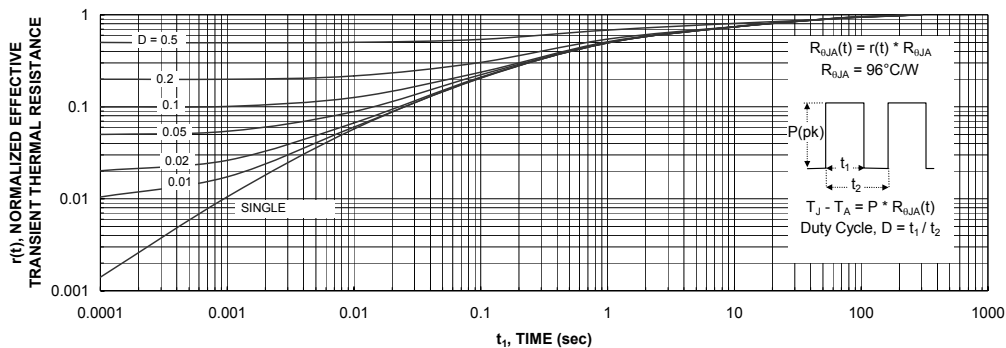


Figure 13. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b.
 Transient thermal response will change depending on the circuit board design.



NOTES: UNLESS OTHERWISE SPECIFIED
A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.

B) ALL DIMENSIONS ARE IN MILLIMETERS.

C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.

D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.

E) TRIMMED METAL CENTER LEAD IS PRESENT ON FOR NON-DIODE PRODUCTS

F) DIMENSIONS ARE EXCLUSIVE OF BURS, MOLD FLASH AND TIE BAR EXTRUSIONS.

G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.

H) DRAWING NUMBER AND REVISION: MKT-TO252A03REV11



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